<u>Onsemí</u>,

MOSFET – N-Channel, QFET

800 V, 3.0 A, 4.8 m Ω

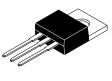
FQP3N80C, FQPF3N80C

Description

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 3.0 A, 800 V, $R_{DS(on)} = 4.8 \Omega$ (Max.) @ $V_{GS} = 10$ V, ID = 1.5 A
- Low Gate Charge (Typ. 13 nC)
- Low C_{rss} (Typ. 5.5 pF)
- 100% Avalanche Tested

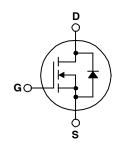




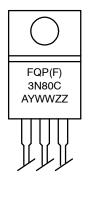
TO-220-3LD CASE 340AT

TO-220 Fullpack, 3-Lead / TO-220F-3SG CASE 221AT

N-CHANNEL MOSFET



MARKING DIAGRAM



FQP(F)3N80C	= Specific Device Code
A	= Assembly Location
YWW	= Date Code (Year & Week)
ZZ	= Assembly Lot

ORDERING INFORMATION

Device	Package	Shipping
FQP3N80C	TO-220-3LD	1,000 Units / Tube
FQPF3N80C	TO-220 Fullpack	1,000 Units / Tube

MOSFET MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Symbol	Parameter		FQP3N80C	FQPF3N80C	Unit	
V _{DSS}	Drain-Source Voltage		800	800	V	
Ι _D	Drain Current	– Continuous ($T_C = 25^{\circ}C$) – Continuous ($T_C = 100^{\circ}C$)	3 1.9	3* 1.9*	A A	
I _{DM}	Drain Current	– Pulsed (Note 1)	12	12*	Α	
V _{GSS}	Gate-Source Voltage		±30	±30	V	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		320	320		
I _{AR}	Avalanche Current (Note 1)		3	3	А	
E _{AR}	Repetitive Avalanche Energy (Note 1)		10.7	10.7	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	4.5	V/ns	
PD	Power Dissipation $(T_C = 25^{\circ}C)$ - Derate Above 25°C		107 0.85	39 0.31	W W/°C	
$T_{J,}T_{STG}$	Operating and Storage Temperature Range	•	–55 to +150	–55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	300	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	FQP3N80C	FQPF3N80C	Unit
R_{\thetaJC}	Thermal Resistance, Junction-to-Case, Max.	1.17	3.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	62.5	°C/W

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS		-			-
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 μ A	800	-	-	V
$\frac{\Delta \text{BV}_{\text{DSS}}}{/\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C	-	1	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 640 \text{ V}, T_{C} = 125^{\circ}\text{C}$	-		10 100	μΑ μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	-	-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	-100	nA
ON CHARA	ACTERISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 1.5 A	-	4.0	4.8	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 50 V, I _D = 1.5 A	-	3	-	S
DYNAMIC	CHARACTERISTICS		-			-
C _{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz	-	543	705	pF
C _{oss}	Output Capacitance	1	-	54	70	pF
C _{rss}	Reverse Transfer Capacitance	1	_	5.5	7.5	pF

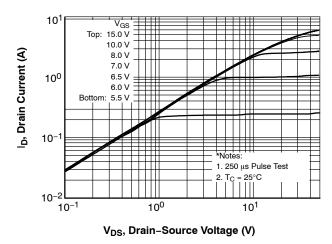
ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)(continued)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
WITCHIN	G CHARACTERISTICS					-
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 3 \text{ A},$	-	15	40	ns
t _r	Turn–On Rise Time	R _G = 25 Ω (Note 4)	-	43.5	95	ns
t _{d(off)}	Turn-Off Delay Time		-	22.5	55	ns
t _f	Turn-Off Fall Time		-	32	75	ns
Qg	Total Gate Charge	V _{DS} = 640 V, I _D = 3 A, V _{GS} = 10 V (Note 4)	-	13	16.5	nC
Q _{gs}	Gate-Source Charge		-	3.4	-	nC
Q _{gd}	Gate-Drain Charge		-	5.8	-	nC

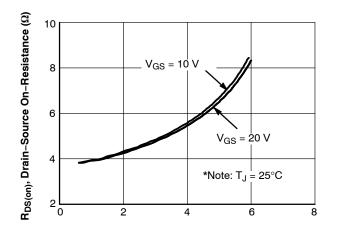
۱ _S	Maximum Continuous Drain-Source Diode Forward Current		-	_	3.0	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	12	Α
V _{SD}	Drain–Source Diode Forward Voltage $V_{GS} = 0 V, I_S = 3.0 A$		-	-	1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 V$, $I_S = 3.0 A$, $dI_F/dt = 100 A/\mu s$		642	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dI = 100 A/\mu s$	-	4.0	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product Product parametric performance is indicated in the Electrical Characteristics for the listed test condition performance may not be indicated by the Electrical Characteristics if operated under different conditions. 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2. L = 67 mH, I_{AS} = 3.0 A, V_{DD} = 50 V, R_G = 25 Ω , starting T_J = 25°C. 3. $I_{SD} \le 3$ A, di/dt $\le 200 \text{ A/}\mu\text{s}$, $V_{DD} \le \text{BV}_{DSS}$, starting T_J = 25°C. 4. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

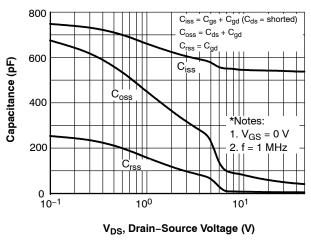






I_D, Drain Current (A)







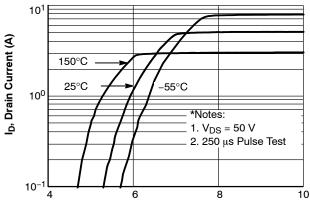
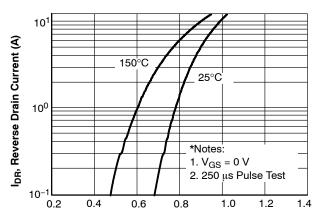
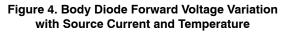




Figure 2. Transfer Characteristics







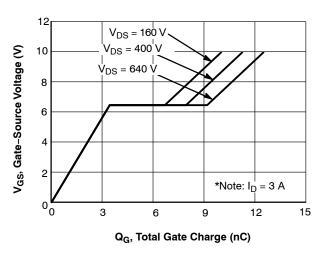
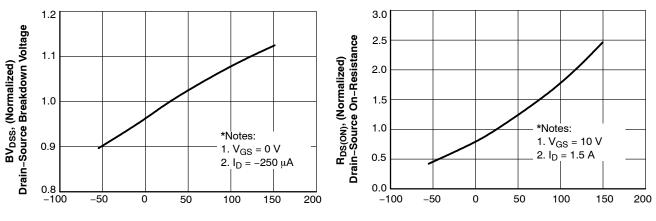
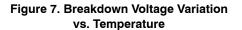


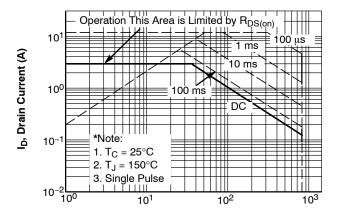
Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (continued)









V_{DS}, Drain-Source Voltage (V)

Figure 9. Maximum Safe Operating Area for FQP3N80C

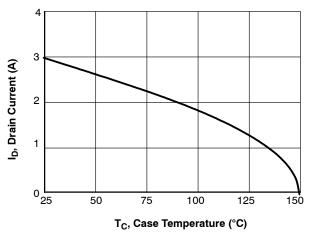
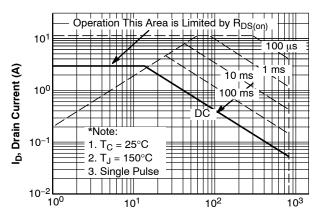


Figure 11. Maximum Drain Current vs. Case Temperature



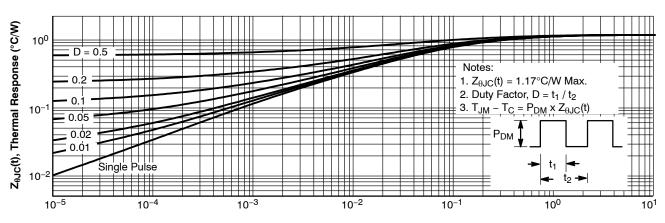
Figure 8. On–Resistance Variation vs. Temperature



V_{DS}, Drain-Source Voltage (V)

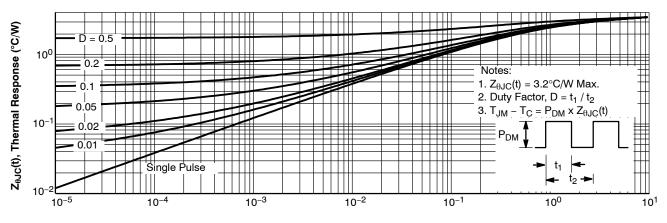


TYPICAL CHARACTERISTICS (continued)



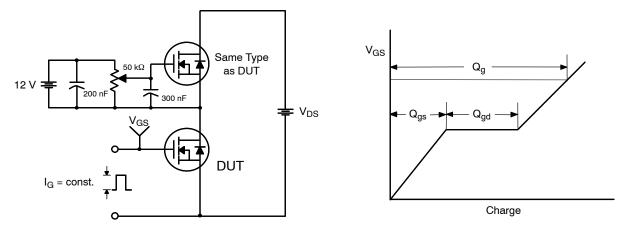
t₁, Square Wave Pulse Duration (s)





t₁, Square Wave Pulse Duration (s)

Figure 13. Transient Thermal Response Curve for FQPF3N80C





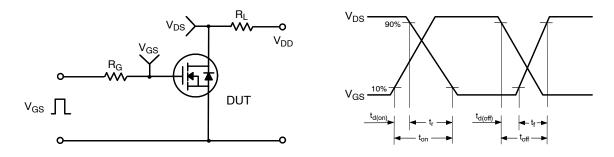


Figure 15. Resistive Switching Test Circuit & Waveforms

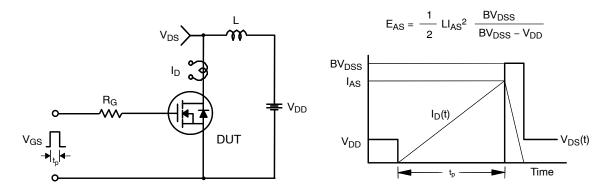


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms

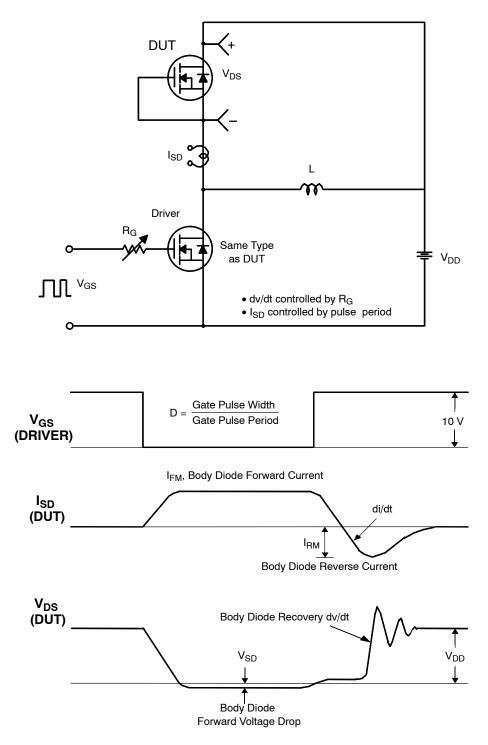
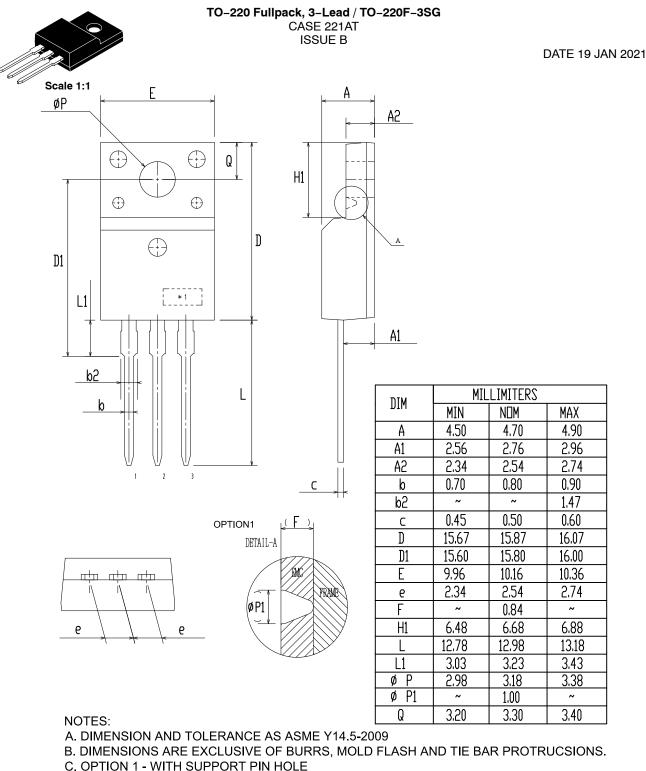


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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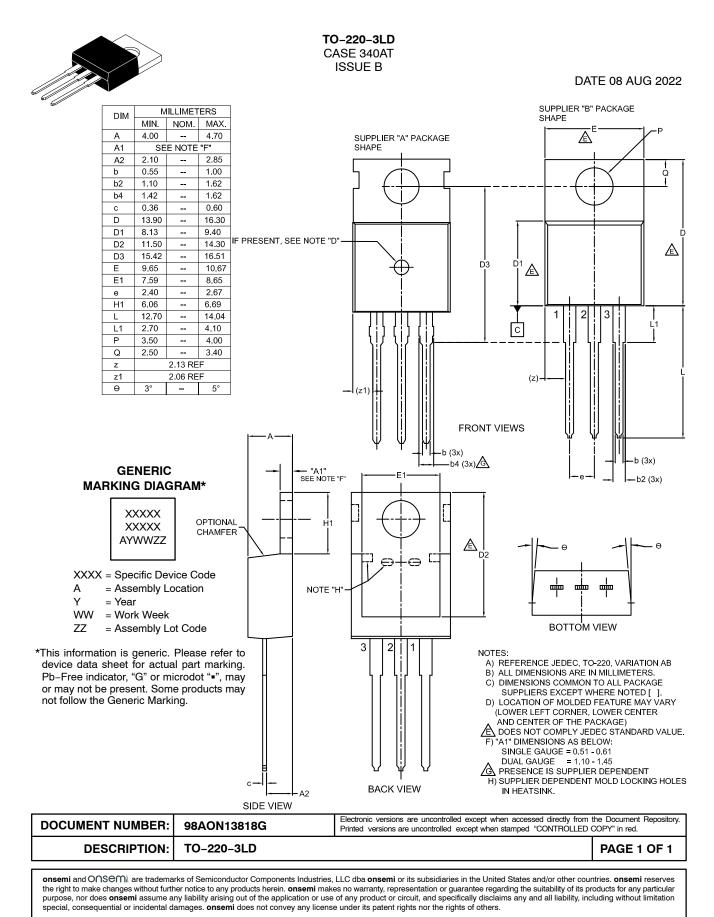


OPTION 2 - NO SUPPORT PIN HOLE

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